

The sensitivity and limitations of present and alternative PV models

Steve Ransome - Independent PV Consultant, SRCL, UK Juergen Sutterlueti – TEL Solar, Switzerland Sandia PV Modelling Workshop; Santa Clara, USA 1st May 2013

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The present status in kWh/kWp measurements and modelling

- Many recent independent outdoor studies find <±5% kWh/kWp (with different rankings between technologies) there's less kWh/kWp variation expected with process optimisation
- Measured kWh/kWp is often dominated by P_{MAX.ACTUAL}/P_{MAX.NOMINAL} tolerance (e.g. "-0%/+3%"); flash test calibration; process variability within bins (e.g. 210-220 Wp); seasonal annealing (particularly thin film); soiling; LID and long term degradation etc.
- Many simulation procedures give "acceptable predictions" kWh/kWp even if they don't model all energy yield affecting parameters correctly





What other approaches to PV modelling are there ?

(as far as is known from user documentation - source code/algorithms are commercially sensitive and are hidden)

Model	Summary	"Advantages"	"Disadvantages"	Comments ?
Estimate Losses/stage e.g. PV Watts	Series of independent losses for each stage	Simple to understand	Correct kWh/kWp may have cancelling input errors	Good initial estimate
1-2 Diode/"n parameter" (fit IV curves to datasheet values)	Lumped element model, 5-7 coefficients	Easy to understand, some physical significance e.g. Rs, Rshunt	Iterative IV equations, unknown Rshunt vs. Gi	Might not model : <u>Module variability</u> Spectral Response Angle of Incidence Direct:Diffuse Seasonal Annealing
Matrix method (IEC 61853)	Efficiency vs. Irradiance and Tmodule	Easy indoor test, can be interpolated outdoor	Still need to correct for AOI, Beam Fraction and Air Mass	
Empirical fits (e.g. PVUSA)	~5 coefficients model P *Gi, *Gi^2, *Gi*Tmod, *Gi*WS +Constant	Extrapolate to STC, Better if normalised to confirm performance	Not all coefficients are physically significant	
Simulation programs (mostly 1 diode PV model.)	Enhanced 1 diode model with Rsh vs. Gi	Powerful and mature code, some validation	Hidden algorithms; can't validate all stages	
Sophisticated Verification (SV)	Sequential losses – unsure efficiency model	Determines many losses, in line check	Might not model all effects	
Sandia Model (King)	29 parameter - fixed tilt and 2D track	Fits almost all PV parameters such as Vmp, Isc	Needs full IV curve, Not all coefficients independent or physical (e.g. AM ⁴)	Good fit to one module may lead to lack of applicability to others
Loss Factors Model (TEL)	8 <u>normalised orthogonal</u> coefficients	Finds independent behaviour of I, V, R, P, α,β,γ vs. Irradiance, time	Needs full IV curve not just Imp, Vmp	See talk Juergen Sutterlueti tomorrow
				for more details





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Some limitations in present models and suggestions for improvements

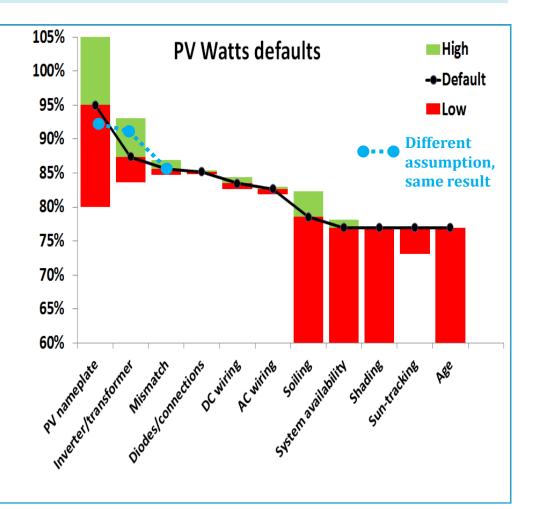
Limitations	Status in present models	Improvements to future models – particularly for thin film, multi junction etc.	
1) Too many unknowns	Potential for self cancelling errors e.g. "better Pactual/Pnominal * worse dirt loss"; Checking only at one site, fixed plane only	Measure and model at more loss stages dc, ac – dc IV, ac Yield, cleaning, 2D vs. fixed Check more sites with different climates, fixed vs. 2D track (to distinguish aoi vs. spectrum)	
2) IV curve fitting errors	Thermal coefficients , low light performance not as datasheet due to unknown Rshunt vs. irradiance	Check model vs. IEC standards ; Model Rshunt vs. irradiance properly	
3) Module performance variability	Databases of PV fits are usually to only one module measurement or datasheet values	We need to understand module variability; PV coefficients need uncertainties and ranges e.g. Isc.mean, ± Isc.stdev	
4) Only PV efficiency is usually modelled	Most modelling only covers efficiency vs. irradiance/temperature (plus simple Vmp for MPP tracking)	Model Rshunt , Rseries and other parameters which may vary with irradiance and time (seasonal changes, degradation) and differentiate technologies	
5) Distribution of irradiance vs. measurement frequency	Insolation vs. Irradiance (kWh/m ² vs. kW/m ²) varies with measurement frequency – hourly averages have more low light insolation	Use minutely or faster model or measurements as it has a more realistic behaviour (more high irradiance peaks) – less important at highest insolation sites. Compare measured vs. modelled data	
6) Weather parameters are all correlated	Most models based on <u>independent</u> indoor coefficients Irradiance, Temperature, Spectrum , Angle of incidence etc.	Correlated weather (no "double counting") High Irradiance ~ High Temperature ~ Low AOI ~ Bluer Skies ~ High Beam fraction ~ low shading etc.	
7) Energy yield determining effects not usually modelled		Need to understand and model more effects Seasonal anneal, Spectral response – particularly TF/Direct Diffuse - Particularly important for thin film, multi junctions etc.	





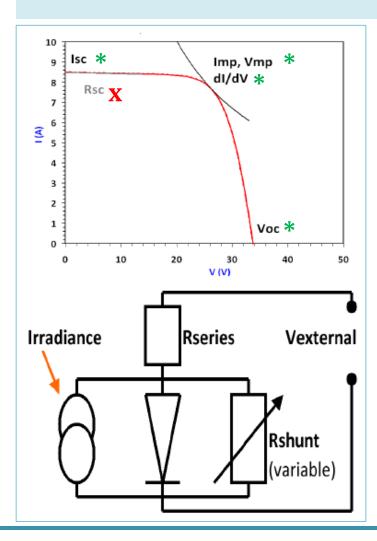
1) Too many unknowns – non unique solutions "Estimate losses per stage" [PVWatts] 2012

- 1. Estimate loss/stage for Shading, Wiring, Soiling etc.
- 2. Multiply loss/stage to give $dc \rightarrow ac loss = \Pi(losses)$
- 3. kWh/kWp = $\Sigma dc \rightarrow ac * "hourly dc model"$
- We need intermediate measurements (e.g. dc) to validate assumptions otherwise there could be self cancelling errors e.g. "Pactual/nominal vs. soiling"
- Agreement with measured kWh/kWp doesn't guarantee every stage is correct as the same result can be achieved with different inputs (see blue bars with worse PV nameplate and better Inverter derating than nominal)





2) IV curve fitting errors 1 diode model / n parameter model (5 \rightarrow 7) etc.



- Fits IV curve from manufacturer datasheets or tested modules
- 4 * "knowns" Isc, (Vmp, Imp), Voc, dI/dV|V=Vmp and 1 guess x - Rsc ~Rshunt
- Original De Soto Model (2005) coefficients determined
 - Temperature dependence (not IEC 61215/61646)
 - Low light level efficiency (not EN 50380)

$$a = \frac{q}{nkT}; \frac{a}{a_{ref}} = \frac{T_c}{T_{c.ref}}$$
$$\frac{Io}{Io, ref} = \left[\frac{Tc}{Tc, ref}\right]^3 e^{\frac{\epsilon Ns}{a_{ref}}} \left(1 - \frac{Tc, ref}{Tc}\right)$$

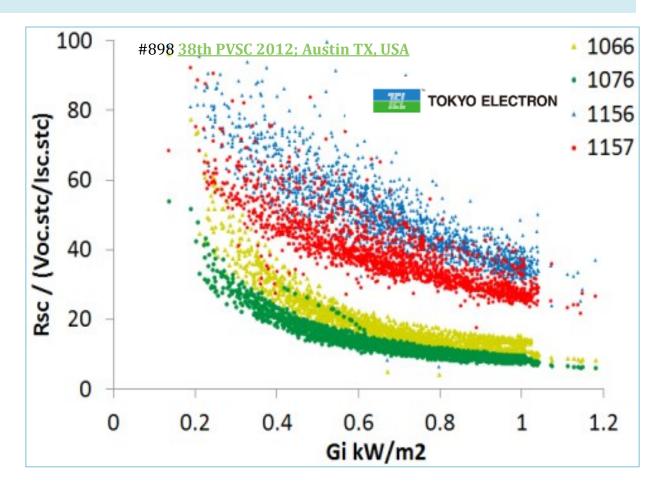
- Some later models alter the n and Io behaviour to try to match the correct temperature coefficients
- 1 diode is not a perfect model it would need variable coefficients to model reality better



2) IV curve fitting errors 1 diode model / n parameter model (5→7) etc.

- Low light behaviour depends mostly on how Rsc rises as irradiance falls
 but this is not yet fully quantified or understood
- Data shows "normalised" Rsc vs Irradiance for 4 different thin film modules in Switzerland. C-Si has a similar shaped behaviour but higher scatter as it's harder to measure as Rsc is much higher for c-Si
- Several models use different Rsc(Gi) behaviours (constant, linear, exponentially varying with irradiance)

OKYO ELECTRON

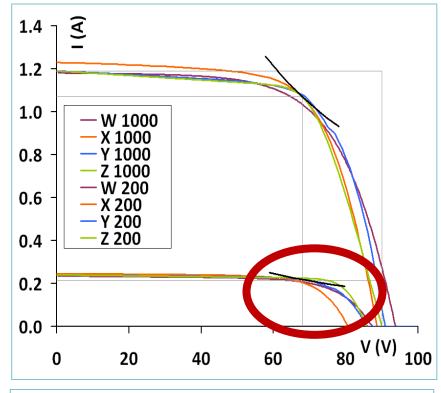




2) IV curve fitting errors 1 diode model / n parameter model (5→7) etc.

Errors in modelled vs. datasheet IV and low light efficiency Rsh=f(Gi)

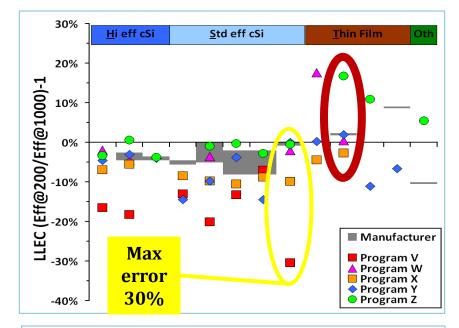
Fits by 5 different 1-diode based simulation programs to typical IV data for 1J-TF at 1000 and 200 W/m²



Check your own modules and programs

Low light efficiency @ 200W/m²

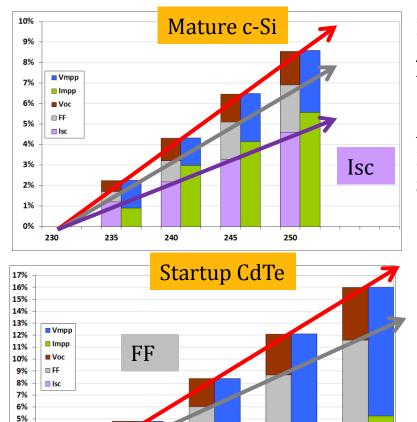
13 PV technologies, 5 simulation programs, reported since 2008 (SRCL started studying this in 2008, this is 2011 data)



Low light efficiency and dPmax/dT discrepancies seen (<u>all</u> PV technologies + simulation programs) **These bias kWh/kWp towards "optimistic" fits** up to 16% energy yield errors have been seen



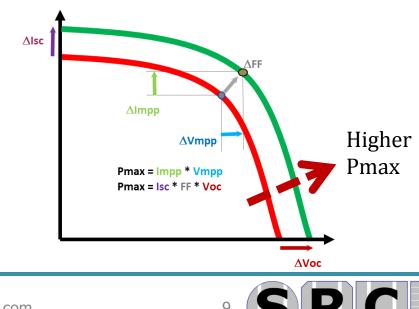
3) Module performance variability in P_{MAX} bins from datasheets – changes with technology and maturity



60

62

Better P_{MAX} bins tend to have higher I_{SC} , V_{OC} etc. $\Delta P_{MAX} \approx \Delta V_{MPP} + \Delta I_{MPP} \approx \Delta V_{OC} + \Delta FF + \Delta I_{SC}$ Values are <u>absolute minimum variation</u> within P_{MAX} bins (assuming perfect Isc and Voc correlation) Also shows maturity of process Mature c-Si – Isc111 FF11 Voc1 Startup CdTe – FF111 Voc11 Isc1 (Rshunt1, Rseries1)



57

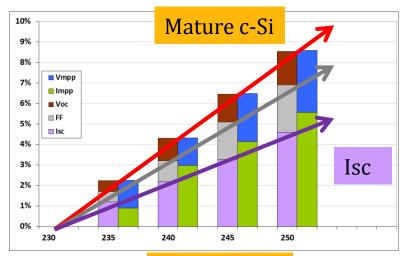
4% 3% 2% 1% 0%

55

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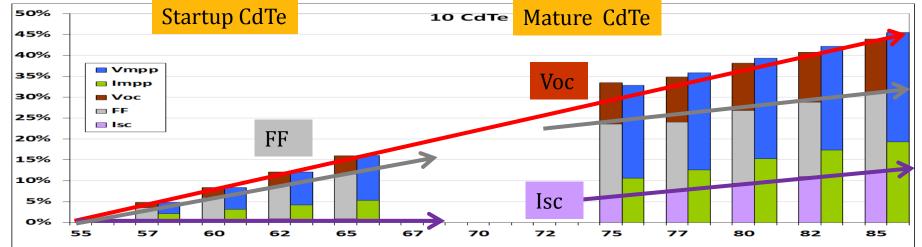
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3) Module performance variability in P_{MAX} bins from datasheets – changes with technology and maturity



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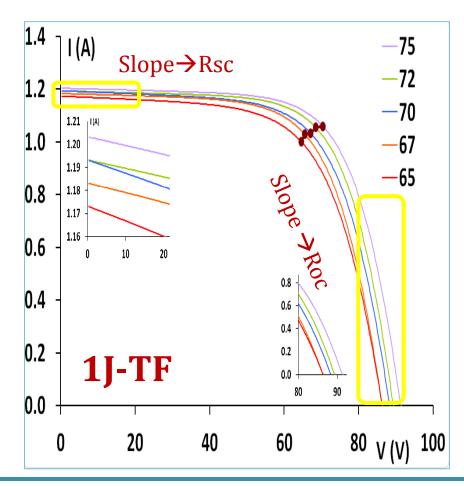
(latest CdTe > 18% – sensitivity may differ as eff. saturates)



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3) Module variability from Random module IV curves vs. Pmax bins \rightarrow kWh/kWp prediction errors



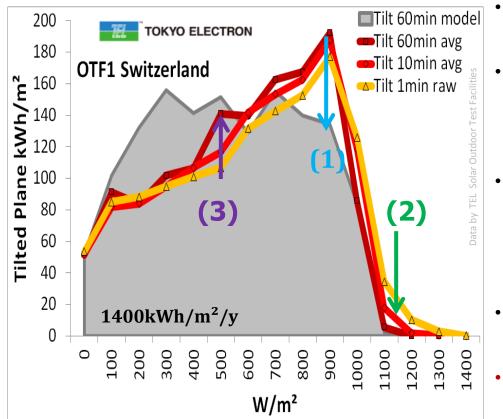
Some manufacturers datasheets have "smooth Isc and Voc changes per W bin" (e.g. 1.0 1.1 1.2A ; 80 81 82 V ...)

Others (see left) have "random" modules per W bin having

- Non linear I_{SC} , V_{OC} , I_{MP} , V_{MP} vs. bin
- Non constant R_{SC} and R_{OC}
- Predicted kWh/kWp will vary between P_{MAX} bins due to random modules in the database rather than averaged interpolations
 - Lower Rsc poor at low insolation sites
 - Higher Roc poor at high insolation sites



5) Distribution of irradiance vs. measurement. frequency Insolation (kWh/m²) vs. irradiance (kW/m²)



- Measured irradiance near 900W/m² much higher than modelled (1)
- Averaging irradiance by time merges scattered cloud conditions (2) (high irradiance with reflection interspersed with diffuse) into "dull data" (3)
- Much more frequent than 1min measurements don't show much higher spikes because of relatively slow cloud speeds and also the time constant of pyranometers (~10secs)
- Discrepancies are less (but non zero) at higher insolation sites
- This distribution change gives errors in any kWh/kWp simulations where Efficiency vs. Irradiance is not constant.
 - Up to 3% errors in kWh/kWp found



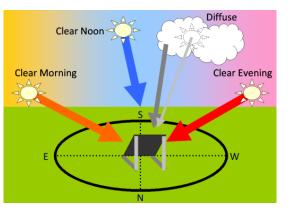
33rd PVSC 2008 San Diego #521

6) Weather variability and difference from STC Most characterisation indoors with independent Irradiance and Tmodule

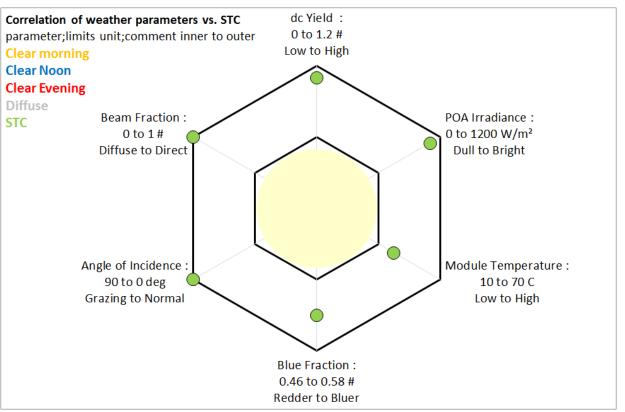
Plotting correlation of energy yield vs. 5 important weather parameters –

Outer ring ~ "high energy yield weather"

Inner ring ~ "lower energy yield weather"

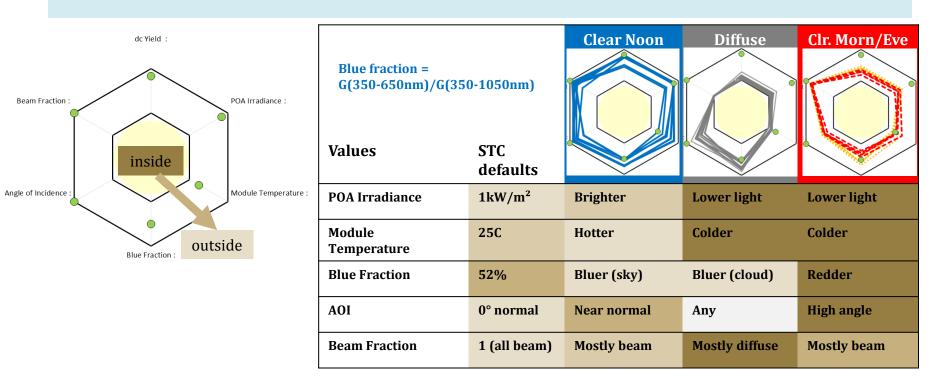


Blue fraction = G(350-650nm)/G(350-1050nm)





6) Weather variability and difference from STC Most characterisation indoors with independent Irradiance and Tmodule



- When determining outdoor coefficients <u>all</u> other parameters need to be measured and corrected for e.g. when measuring temperature coefficients we need to correct for spectrum, aoi ... as they all have an effect.
- Thin film temperature coefficients may appear positive if spectrum and annealing aren't corrected properly
- Weather correlation means horizon shading removes irradiance under red rich, high aoi, cooler conditions etc. don't "double count" losses





Typical model output Efficiency(Irradiance, module temperature)

PV relative Eff/STC vs Irradiance kW/m² Gamma dP/dT dP/dT 110% $1/\eta * d(\eta)/dTmod$ 100% **STC** LLEC Low light LLEC Relative Eff/STC 90% $(\eta_{200}/\eta_{1000}) W/m^2$ 80% -10 NOCT -25 $(Irrad = 800W/m^2)$, 70% AM = 1.5, -40 T_{AMB} = 20C, -55 60% wind = 1ms^{-1}) -70 50% 0.2 0.6 0 0.4 1 0.8 Irradiance kW/m²

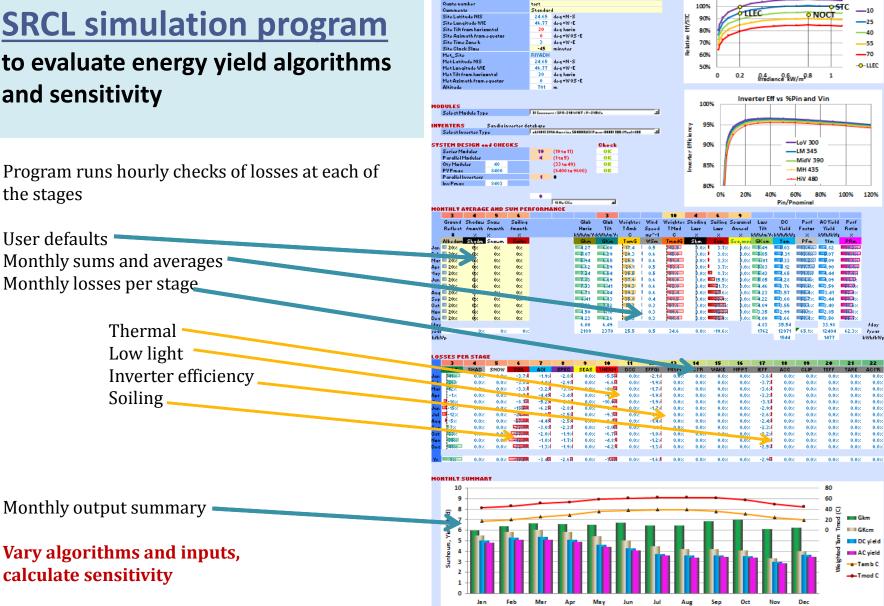
NOCT

SRCL simulation program

to evaluate energy yield algorithms and sensitivity

Program runs hourly checks of losses at each of the stages

User defaults Monthly sums and averages Monthly losses per stage



SETUP

Date and Time

BIYADH, SA Lat-24,65 Lpn-1 Alt-701 Azi-0 Tilt-30 T2-3

04 Fab 2013

SBOL

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0.0%

0.02

0.02

0.0%

0.0%

PV relative Eff/STC vs Irradiance kW/m²

110%

"Default" and "Better" inputs for simulation and how their values may be improved

also shows sensitivity to unknowns or errors

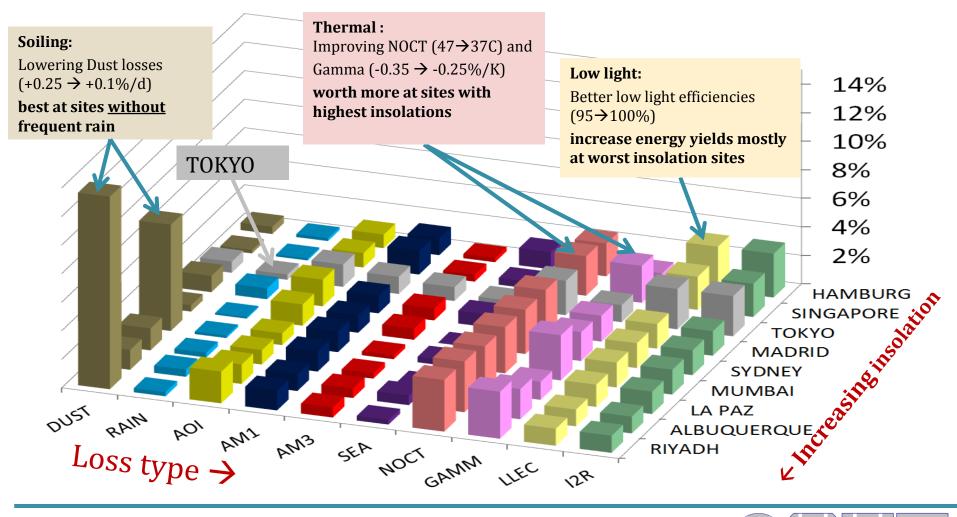
Input: Comment (How to improve ?)	Default	"Better"
Dust: Daily soil increase (washing, cleaning ?)	+0.25 %/d	+0.1 %/d
Rain: Min. day rainfall to clean (stay clean coating ?)	2 mm	1 mm
AOI: Angular reflectance (ARC, textured glass)	85% @ 75°	95% @ 75°
AM1, AM3: Eff@AM3 or AM1 /Eff@AM1.5 (Improve red or blue response for multijunction)	95%	98%
Seasonal Anneal: Oscillation -Spring +Autumn (see seasonal anneal section)	±0 %	±3%/K
NOCT: (Nominal operating cell temperature) (Passive cooling fins ?, forced ventilation)	47 C	37 C
Gamma: 1/P _{MAX} * dP _{MAX} /dT (reduces with high Voc)	-0.35 %/K	-0.25 %/K
LLEC: Low light efficiency Eff ₂₀₀ /Eff ₁₀₀₀ W/m ² Improve Rshunt, uniformity	95 %	100 %
I2R: Series resistance loss in cell (Lower Rseries, better bus bars, tabbing etc.)	95%	100%





Energy yield sensitivity to input changes or errors - compare with extra manufacturing cost for LCOE

See SRCL talk in PVSC Tampa 2013 for more details



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SRCL

7) Energy yield determining effects which can be included / improved for better PV modelling (see Juergen Sutterlueti's talk tomorrow)

- Rsc vs. Irradiance
- Angle of Incidence (AOI) differences between module and sensor
- Fixed plane vs. 2D tracking
- Spectral response
- Low vs. high horizon
- Current matching (multi junction devices)
- Seasonal annealing
- (Light induced) degradation (LID)
- Soiling & cleaning impact (see Dust Detection System by TEL TWN team)
- Production quality distribution

• ..

All required for improved kWh/kWp or ct/kWh analysis!

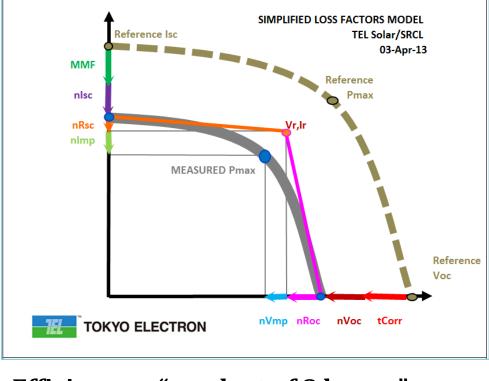






Loss factors model(LFM) IV curve fit

[TEL1] "Understanding Module Performance further: validation of the novel loss factors model and its extension to ac arrays" Sellner et al, 27th PVSEC Frankfurt 2012



Efficiency ~ "product of 8 losses" [MMF * nIsc * nRsc * nImp] * ←I [nVmp * nRoc * nVoc * tCorr] ←V 8 physical, normalised, orthogonal losses <u>not just efficiency</u>

Works with

- all PV technologies tested
 - (a-Si, a-Si:uc-Si, CdTe, CIGS, c-Si, HIT ...)
- Different sites
 - (Switzerland, Arizona ...)
- All weather
 - (Clear noon, morning, evening or cloudy)
- Pyranometer and/or c-Si reference cell
- Fixed plane or 2D tracker
- Can validate performance and predict energy yield
- Simplified diagram shown



Conclusions

- Models need to check every stage not just kWh/kWp (self cancelling errors)
- <u>Rsc vs. Irradiance</u> affects low light efficiency most, it's not on datasheets
- Modelled low light and temperature coefficients must agree with IEC measurements discrepancies cause errors up to 16% kWh/kWp
- We need a better understanding of
 - Module variability Δ Isc, Δ Voc, Δ FF etc. are technology dependent
 - Irradiance and module spectral response
 - Irradiance averaging frequency
 - Correlated weather parameters
 - Seasonal annealing (for some thin films)
 - Measurements vs. Irradiance sensor type etc.
- LFM is being developed with TEL Solar to overcome many of these modelling problems – but it needs spectral measurements and seasonal anneal modelling for thin film - Further talk tomorrow by Juergen Sutterlueti (TEL)





Some links

[TEL1] "Understanding Module Performance further: validation of the novel loss factors model and its extension to ac arrays" Sellner et al, TEL, 27th PVSEC Frankfurt 2012

http://www.steveransome.com/PUBS/2012Frankfurt_4E035_OutdoorPerformance_LFM_Sellner_et_al.pdf

[TEL2] "Characterising PV Modules under Outdoor Conditions: What's Most Important for Energy Yield" Sutterlueti et al 26th PVSEC Hamburg 2011 http://www.steveransome.com/pubs/2011Hamburg 4AV2 41.pdf

[Hans] "Calibration of the Sandia Array Performance Model Using Indoor Measurements" Hansen et al, Sandia, 38th PVSC Austin 2012

[TUV] "COMPARISON OF DIFFERENT THIN-FILM TECHNOLOGIES - PERFORMANCE CHARACTERISTICS OBTAINED FROM LABORATORY AND FIELD TESTS" 25th PVSEC Valencia 2010

[Stein] "The Photovoltaic Performance Modelling Collaborative (PVPMC)" <u>www.pvpmc.org</u>

[Tok2] "PERFORMANCE DEGRADATION ANALYSES OF DIFFERENT KINDS OF PV TECHNOLOGIES IN HOKUTO MEGA SOLAR PROJECT" UEDA et al Tokyo institute of Technology 26th PVSEC Hamburg 2011

[BPS] "How well do PV modelling algorithms really predict performance?" Ransome 22nd PVSEC Milan 2007

http://www.steveransome.com/PUBS/2007Milan_4EP_1_1_paper.pdf

[DKA] <u>http://www.dkasolarcentre.com.au/go/gallery/gallery</u>

[SRCL] http://www.steveransome.com

[King] http://energy.sandia.gov/wp/wp-content/gallery/uploads/075036.pdf

[PVGIS] http://re.jrc.ec.europa.eu/pvgis/

[Pvsyst] http://www.pvsyst.com

[TMY] http://www.nrel.gov/docs/fy08osti/43156.pdf

[TEL] Tel Solar http://www.solar.tel.com/

[PVWATTS] <u>http://rredc.nrel.gov/solar/calculators/pvwatts/version1/US/US text only.html</u>





Thank you for your attention !

steve@steveransome.com past papers available at www.steveransome.com acknowledgements : TEL Solar

Next conferences/visits planned

<u>39th PVSC 16-21 Jun 2013 Tampa, Florida, USA</u> "Estimating the Sensitivity of Energy Performance from Optimising Different PV Technologies World Wide" by Steve Ransome (SRCL) and Juergen Sutterlueti (TEL) System Performance Modeling, 17 June 2013 @ 3:30PM

28th EU PVSEC 30 Sep-04 Oct 2013 Paris, France 2 abstracts submitted – awaiting status (1 oral 1 poster accepted)



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Spare slides



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Simple Empirical equations (similar to PVUSA method)

[SRCL] 35th PVSC 2010

- Simple equations with ~5 independent parameters to model PV performance (Module Temperature, Vmax, Pmax)
- Interpolations/extrapolations find performance at given conditions such as STC or PTC
- Normalise for validity and applicability e.g. Pmeasured/Pnominal.stc

Best use

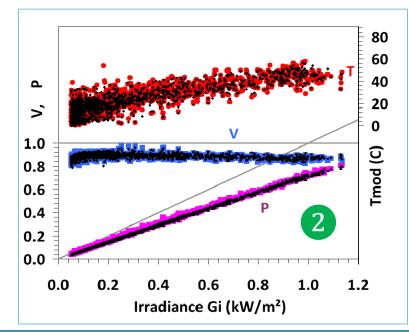
- Commissioning (in non optimum weather)
- Estimating Pmax.actual/Pmax.nameplate
- check for degradation (slow changes)
- failure checking (rapid changes)
- simulating inline performance

$$P = G * (A + B * G + C * T_{MOD} + D * Ws)$$
PVUSA

$$T_{MOD} = C_{TM} * T_{AMB} + G * (A_{TM} + D_{TM} * WS) + E_{TM}$$

$$V_{MP}/V_{MP,STC} = A_{MP} * LOG_{10}(G) + \frac{B_{MP}}{G} + C_{MP} * T_{MOD} + D_{MP} * WS + E_{MP}$$

$$YA = \frac{P_{dc}}{P_{dc,STC}} = G * (A_{YA} + B_{YA} * G + C_{YA} * T_{MOD} + D_{YA} * WS) - E_{YA}$$
Normalised





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System performance - Sophisticated Verification method

[Tok2] "PERFORMANCE DEGRADATION ANALYSES OF DIFFERENT KINDS OF PV TECHNOLOGIES IN HOKUTO MEGA SOLAR PROJECT" UEDA et al Tokyo institute of Technology 26th PVSEC Hamburg 2011

Series of independent losses to model system efficiency 1. Shading (S) 2. Effective array peak power (*AP*) 3. Reflection (*R*) 4. Spectral mismatch (SM) 5. Module temperature (T) 6. PCS capacity shortage (*PS*) 7. Grid voltage (GV) 8. Operating point mismatch (high voltage) (*MH*) 9. Fluctuation (F) 10. DC circuit (DC) 11. PCS (Inverter) (PC) 12. PCS Off / PCS Standby (off) 13. Miscellaneous loss and error (*Er*). Unknown what PV efficiency model is used ...

